Issue Classification

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ORIGINAL

Applicatio	n/Con	trol	No
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10765675

AMER-YAHIA ET AL.

INTERNATIONAL CLASSIFICATION

Applicant(s)/Patent Under Reexamination

Examiner

Art Unit

Harper, Leon J

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Harper, Leon J 11/10/07 (Assistant Examiner) (Date)			Macem							Total Claims Allowed:						
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